

ON Semiconductor®

FGH40T65SH 650 V, 40 A Field Stop Trench IGBT

Features

- Maximum Junction Temperature : T_J = 175°C
- Positive Temperature Co-efficient for Easy Parallel Operating
- · High Current Capability
- Low Saturation Voltage: V_{CE(sat)} = 1.6 V(Typ.) @ I_C = 40 A
- 100% of the Parts Tested for I_{LM}(1)
- · High Input Impedance
- · Fast Switching
- · Tighten Parameter Distribution
- RoHS Compliant

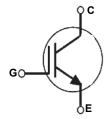
General Description

Using novel field stop IGBT technology, ON Semiconductor's new series of field stop 3rd generation IGBTs offer the optimum performance for solar inverter, UPS, welder, telecom, ESS and PFC applica-tions where low conduction and switching losses are essential.

Applications

· Solar Inverter, UPS, Welder, Telecom, ESS, PFC





Absolute Maximum Ratings T_C = 25°C unless otherwise noted

Symbol	Description		FGH40T65SH	Unit	
V _{CES}	Collector to Emitter Voltage		650	V	
V_{GES}	Gate to Emitter Voltage		± 20	V	
V GES	Transient Gate to Emitter Voltage		± 30	V	
I _C	Collector Current	@ T _C = 25°C	80	Α	
	Collector Current	@ T _C = 100°C	40	А	
I _{LM (1)}	Pulsed Collector Current	@ T _C = 25°C	120	Α	
I _{CM (2)}	Pulsed Collector Current		120	А	
P_{D}	Maximum Power Dissipation	@ T _C = 25°C	268	W	
	Maximum Power Dissipation	@ T _C = 100°C	134	W	
TJ	Operating Junction Temperature		-55 to +175	°C	
T _{stg}	Storage Temperature Range		-55 to +175	°C	
T _L	Maximum Lead Temp. for soldering Purposes, 1/8" from case for 5 seconds		300	°C	

Notes

- 1. V_{CC} = 400 V, V_{GE} = 15 V, I_{C} =120 A, R_{G} = 41.6 Ω , Inductive Load
- 2. Repetitive rating: Pulse width limited by max. junction temperature

Thermal Characteristics

Symbol	Parameter	FGH40T65SH	Unit	
$R_{\theta JC}$	Thermal Resistance, Junction to Case, Max.	0.56	°C/W	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient, Max.	40	°C/W	

Package Marking and Ordering Information

Part Number	Top Mark	Package	Packing Method	Reel Size	Tape Width	Quantity
FGH40T65SH-F155	FGH40T65SH	TO-247 G03	Tube	-	-	30

Electrical Characteristics of the IGBT $T_C = 25^{\circ}\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
Off Charac	teristics					
BV _{CES}	Collector to Emitter Breakdown Voltage	V_{GE} = 0V, I_C = 1 mA	650	-	-	V
ΔBV _{CES} / ΔΤ _J	Temperature Coefficient of Breakdown Voltage	I _C = 1 mA, Reference to 25°C	-	0.6	-	V/°C
I _{CES}	Collector Cut-Off Current	V _{CE} = V _{CES} , V _{GE} = 0 V	-	-	250	μА
I _{GES}	G-E Leakage Current	$V_{GE} = V_{GES}, V_{CE} = 0 V$	-	-	±400	nA
On Charac	teristics					
V _{GE(th)}	G-E Threshold Voltage	I_C = 40 mA, V_{CE} = V_{GE}	4.0	5.5	7.5	V
. ,		I _C = 40 A, V _{GE} = 15 V	-	1.6	2.1	V
V _{CE(sat)}	Collector to Emitter Saturation Voltage	I _C = 40 A, V _{GE} = 15 V, T _C = 175°C	-	2.14	-	٧
Dvnamic C	Characteristics		_	l		
C _{ies}	Input Capacitance		-	1995	-	pF
C _{oes}	Output Capacitance	$V_{CE} = 30 \text{ V}, V_{GE} = 0 \text{ V},$	-	70	-	pF
C _{res}	Reverse Transfer Capacitance	f = 1MHz	-	23	-	pF
Switching	Characteristics					
t _{d(on)}	Turn-On Delay Time		-	19.2	-	ns
t _r	Rise Time		-	34.4	-	ns
t _{d(off)}	Turn-Off Delay Time	V _{CC} = 400 V, I _C = 40 A,	-	65.6	-	ns
t _f	Fall Time	$R_G = 6 \Omega$, $V_{GE} = 15 V$,	-	9.6	-	ns
E _{on}	Turn-On Switching Loss	Inductive Load, T _C = 25°C	-	1010	-	uJ
E _{off}	Turn-Off Switching Loss		-	297	-	uJ
E _{ts}	Total Switching Loss		-	1307	-	uJ
t _{d(on)}	Turn-On Delay Time		-	18.4	-	ns
t _r	Rise Time		-	32.8	-	ns
t _{d(off)}	Turn-Off Delay Time	V_{CC} = 400 V, I_{C} = 40 A, R_{G} = 6 Ω , V_{GE} = 15 V, Inductive Load, T_{C} = 175°C	-	71.2	-	ns
t _f	Fall Time		-	14.4	-	ns
E _{on}	Turn-On Switching Loss		-	1390	-	uJ
E _{off}	Turn-Off Switching Loss		-	541	-	uJ
E _{ts}	Total Switching Loss		-	1931	-	uJ

Electrical Characteristics of the IGBT (Continued)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max	Unit
Qg	Total Gate Charge	V _{CE} = 400 V, I _C = 40 A, V _{GE} = 15 V	-	72.2	-	nC
Q _{ge}	Gate to Emitter Charge		-	13.5	-	nC
Q _{gc}	Gate to Collector Charge		-	28.5	-	nC

Typical Performance Characteristics

Figure 1. Typical Output Characteristics

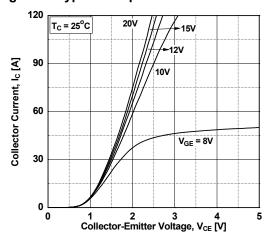


Figure 3. Typical Saturation Voltage Characteristics

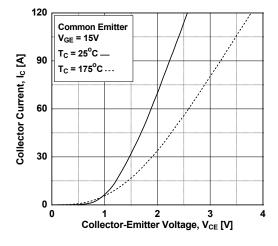


Figure 5. Saturation Voltage vs. V_{GE}

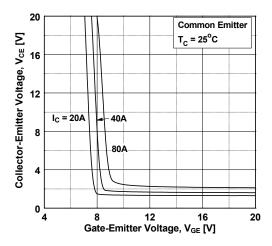


Figure 2. Typical Output Characteristics

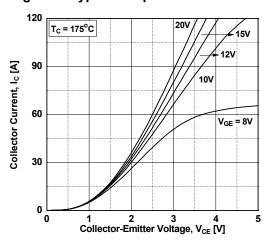


Figure 4. Saturation Voltage vs. Case
Temperature at Variant Current Level

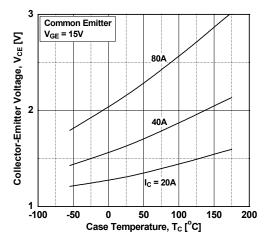
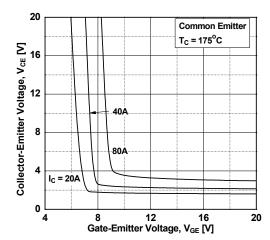


Figure 6. Saturation Voltage vs. V_{GE}



Typical Performance Characteristics

Figure 7. Capacitance Characteristics

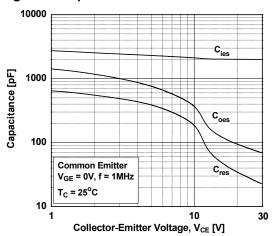


Figure 9. Turn-on Characteristics vs.
Gate Resistance

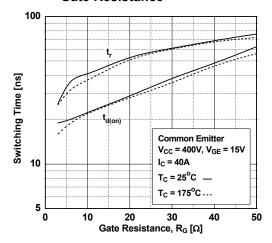


Figure 11. Switching Loss vs.
Gate Resistance

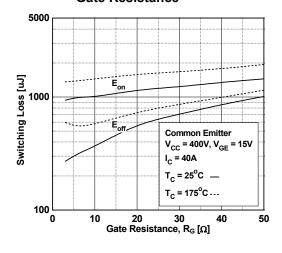


Figure 8. Gate charge Characteristics

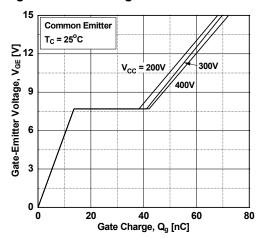


Figure 10. Turn-off Characteristics vs. Gate Resistance

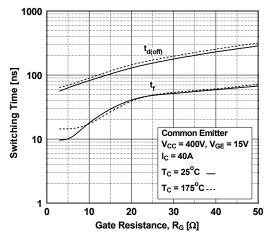
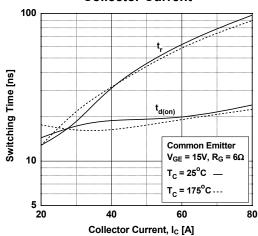


Figure 12. Turn-on Characteristics vs. Collector Current



Typical Performance Characteristics

Figure 13. Turn-off Characteristics vs. Collector Current

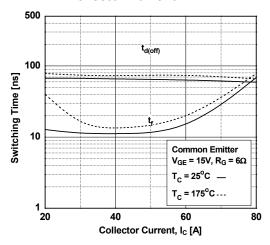


Figure 14. Switching Loss vs. Collector Current

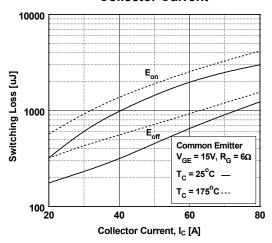


Figure 15. Load Current Vs. Frequency

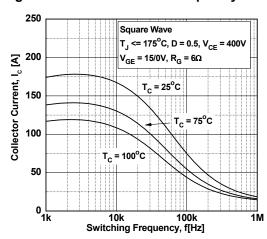


Figure 16. SOA Characteristics

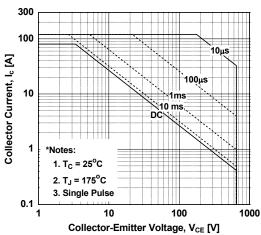
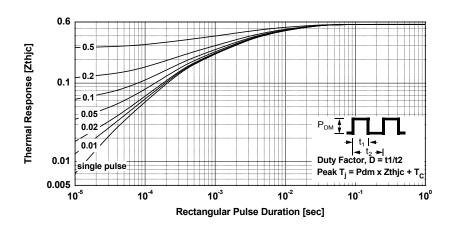


Figure 17.Transient Thermal Impedance of IGBT



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